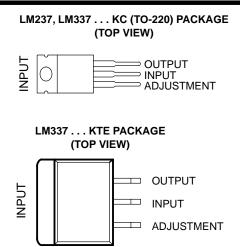
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- Output Voltage Range Adjustable From -1.2 V to -37 V
- Output Current Capability of 1.5 A Max
- Input Regulation Typically 0.01% Per Input-Voltage Change
- Output Regulation Typically 0.3%
- Peak Output Current Constant Over Temperature Range of Regulator
- Ripple Rejection Typically 77 dB
- Direct Replacement for National Semiconductor LM237 and LM337



#### description/ordering information

The LM237 and LM337 are adjustable 3-terminal negative-voltage regulators capable of supplying in excess of -1.5 A over an output voltage range of -1.2 V to -37 V. They are exceptionally easy to use, requiring only two external resistors to set the output voltage and one output capacitor for frequency compensation. The current design has been optimized for excellent regulation and low thermal transients. In addition, the LM237 and LM337 feature internal current limiting, thermal shutdown, and safe-area compensation, making them virtually immune to failure by overloads.

The LM237 and LM337 serve a wide variety of applications, including local on-card regulation, programmable output-voltage regulation, and precision current regulation.

Тј	PACKAGET		ORDERABLE PART NUMBER	TOP-SIDE MARKING
–25°C to 150°C	TO-220 (KC)	Tube of 50	LM237KC	LM237
0°C to 125°C	POWER-FLEX (KTE)	Reel of 2000	LM337KTER	LM337
0 0 10 125 0	TO-220 (KC)	Tube of 50	LM337KC	LM337

#### **ORDERING INFORMATION**

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

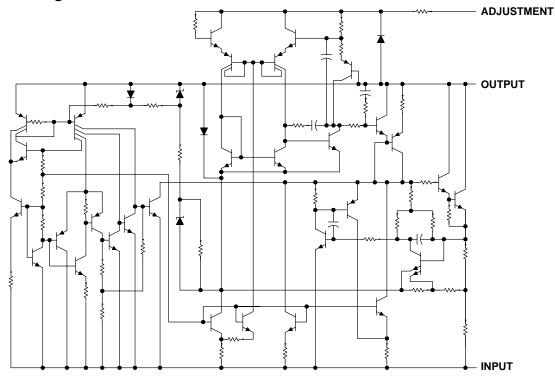
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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#### schematic diagram



## absolute maximum ratings over operating temperature ranges (unless otherwise noted)<sup>†</sup>

Input-to-output differential voltage, V <sub>I</sub> – V <sub>O</sub> –	-40 V
Operating virtual junction temperature, T <sub>J</sub> 1	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	60°C
Storage temperature range, T <sub>stg</sub>	50°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### package thermal data (see Note 1)

PACKAGE	BOARD	θJC	$\Theta_{\mathbf{JA}}$
POWER-FLEX (KTE)	High K, JESD 51-5	3°C/W	23°C/W
TO-220 (KC)	High K, JESD 51-5	3°C/W	19°C/W

NOTE 1: Maximum power dissipation is a function of  $T_J(max)$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(max) - T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability.

### recommended operating conditions

					MIN	MAX	UNIT
	$ V_{I} - V_{O}  \le 40 V,$	$P \le 15 W$		10	1500	<b>~</b> ^	
IO Output current		$ V_{I} - V_{O}  \le 10 V$ ,	$P \le 15 W$		6	1500	mA
T <sub>1</sub> Operating virtual junction temperature				LM237	-25	150	°C
'J				LM337	0	125	0



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	TEST CONDITIONS <sup>†</sup>		LM237		LM337				
PARAMETER			MIN	ТҮР	MAX	MIN	TYP	MAX	UNIT
Input regulation‡	$V_{I} - V_{O} = -3 V$ to $-40 V$	T <sub>J</sub> = 25°C		0.01	0.02		0.01	0.04	%/V
		$T_J = MIN \text{ to } MAX$		0.02	0.05		0.02	0.07	
	V <sub>O</sub> = -10 V,	f = 120 Hz		60			60		dB
Ripple rejection	V <sub>O</sub> = -10 V, f = 120 Hz,	$C_{ADJ} = 10  \mu F$	66	77		66	77		
	IO = 10 mA to 1.5 A,	$ V_{O}  \le 5 V$			25			50	mV
Output regulation	$T_J = 25^{\circ}C$	$ V_{O}  \ge 5 V$		0.3%	0.5%		0.3%	1%	
Oulput regulation	I <sub>O</sub> = 10 mA to 1.5 A	$ V_{O}  \le 5 V$			50			70	mV
		$ V_{O}  \ge 5 V$			1%			1.5%	
Output-voltage change with temperature	$T_{J} = MIN$ to MAX			0.6%			0.6%		
Output-voltage long-term drift	After 1000 h at T <sub>J</sub> = MAX an	nd V <sub>I</sub> – V <sub>O</sub> = –40 V		0.3%	1%		0.3%	1%	
Output noise voltage	f = 10 Hz to 10 kHz,	T <sub>J</sub> = 25°C		0.003%			0.003%		
Minimum output	$ V_I - V_O  \le 40 V$			2.5	5		2.5	10	mA
current to maintain regulation	$ V_I - V_O  \le 10 \text{ V}$			1.2	3		1.5	6	
Peak output current	$ V_I - V_O  \le 15 V$		1.5	2.2		1.5	2.2		А
	$ V_{I} - V_{O}  \le 40 V,$	TJ = 25°C	0.24	0.4		0.15	0.4		A
Adjustment-terminal current				65	100		65	100	μA
Change in adjustment-terminal current	$V_I - V_O = -2.5$ V to -40 V, I <sub>O</sub> = 10 mA to MAX	T <sub>J</sub> = 25°C,		2	5		2	5	μΑ
Reference voltage	$V_{I} - V_{O} = -3 V \text{ to } -40 V,$	TJ = 25°C	-1.225	-1.25	-1.275	-1.213	-1.25	-1.287	V
(output to ADJ)	$I_0 = 10 \text{ mA to } 1.5 \text{ A},$	_1 2	_1 25	_1 3	_1 2	_1 25	_1 3	v	

electrical characteristics over recommended ranges of operating virtual junction temperature (unless otherwise noted)

<sup>†</sup> Unless otherwise noted, these specifications apply for the following test conditions  $|V_1 - V_0| = 5$  V and  $I_0 = 0.5$  A. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. All characteristics are measured with a 0.1-µF capacitor across the input and a 1-µF capacitor across the output. Pulse-testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

-1.2

-1.25

0.002

-1.2

-1.3

0.02

-1.25

0.003

-1.3

0.04

%/W

 $T_J = MIN$  to MAX

10-ms pulse

<sup>‡</sup> Input regulation is expressed here as the percentage change in output voltage per 1-V change at the input.

 $P \leq$  rated dissipation Initial T<sub>J</sub> =  $25^{\circ}$ C,

Thermal regulation



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## electrical characteristics, $T_J = 25^{\circ}C$

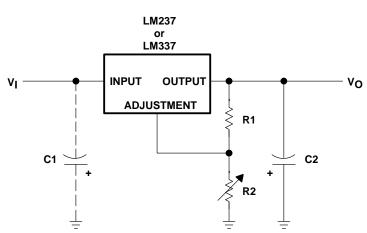
DADAMETED	TEAT CONDITIO	LM237, LM337				
PARAMETER	TEST CONDITIO	MIN	TYP	MAX	UNIT	
Input regulation <sup>‡</sup>	$V_I - V_O = -3 V$ to $-40 V$			0.01	0.04	%/V
Dinale rejection	V <sub>O</sub> = -10 V, f = 120 Hz			60		- D
Ripple rejection	$V_O = -10 \text{ V}, \qquad C_{ADJ} = 10 \mu\text{F},$	f = 120 Hz	66	77		dB
Output regulation	$l_{n} = 10 \text{ m}$ to 1.5 Å	V <sub>O</sub>   ≤ 5 V			50	mV
Output regulation	$I_{O} = 10 \text{ mA to } 1.5 \text{ A}$	$ V_{O}  \ge 5 V$		0.3%	1%	
Output noise voltage	f = 10 Hz to 10 kHz			0.003%		
Minimum output oursent to maintain regulation	VI – VO  ≤ 40 V		2.5	10	~	
Minimum output current to maintain regulation	$ V_{I} - V_{O}  \le 10 V$		1.5	6	mA	
Dook output ourroat	$ V_I - V_O  \le 15 V$			2.2		•
Peak output current	V <sub>I</sub> – V <sub>O</sub>   ≤ 40 V	0.15	0.4		A	
Adjustment-terminal current				65	100	μA
Change in adjustment-terminal current	$V_{I} - V_{O} = -2.5 V$ to $-40 V$ , I <sub>C</sub>	= 10 mA to MAX		2	5	μA
Reference voltage (output to ADJ)	$V_I - V_O = -3 V$ to -40 V, $I_C$ P $\leq$ rated dissipation	= 10 mA to 1.5 A,	-1.213	-1.25	-1.287	V

<sup>†</sup> Unless otherwise noted, these specifications apply for the following test conditions  $|V_I - V_O| = 5 V$  and  $I_O = 0.5 A$ . All characteristics are measured with a 0.1- $\mu$ F capacitor across the input and a 1- $\mu$ F capacitor across the output. Pulse-testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

<sup>‡</sup> Input regulation is expressed here as the percentage change in output voltage per 1-V change at the input.



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### **APPLICATION INFORMATION**

R1 is typically 120 Ω.

R2 = R1
$$\left(\frac{\forall O}{-1.25} - 1\right)$$
 where V<sub>O</sub> is the output in volts.

C1 is a  $1-\mu F$  solid tantalum capacitor required only if the regulator is more than 10 cm (4 in) from the power-supply filter capacitor. C2 is a  $1-\mu F$  solid tantalum or  $10-\mu F$  aluminum electrolytic capacitor required for stability.

### Figure 1. Adjustable Negative-Voltage Regulator

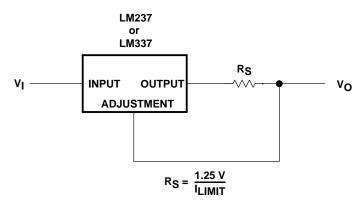
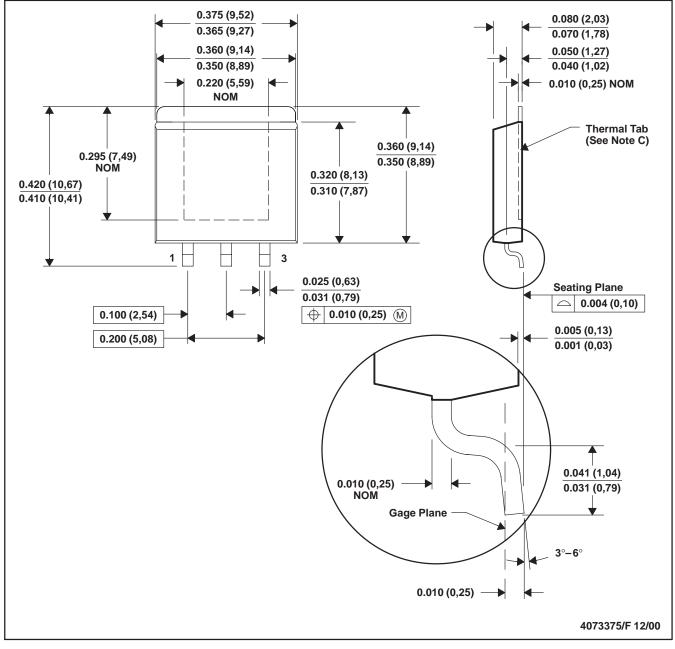


Figure 2. Current-Limiting Circuit



MPFM001E - OCTOBER 1994 - REVISED JANUARY 2001

#### PowerFLEX<sup>™</sup> PLASTIC FLANGE-MOUNT



- NOTES: A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. The center lead is in electrical contact with the thermal tab.
  - D. Dimensions do not include mold protrusions, not to exceed 0.006 (0,15).
  - E. Falls within JEDEC MO-169

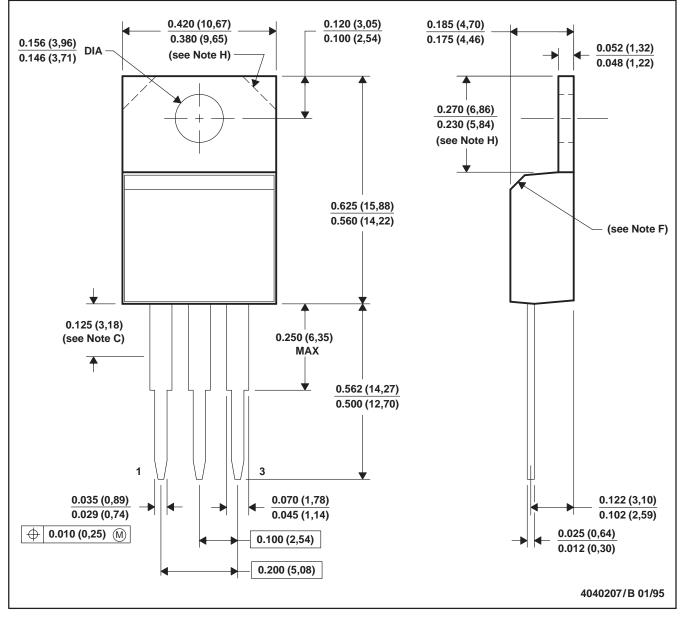
**KTE (R-PSFM-G3)** 

PowerFLEX is a trademark of Texas Instruments.

## **MECHANICAL DATA**

MSOT007A - JANUARY 1995 - REVISED SEPTEMBER 1995

#### PLASTIC FLANGE-MOUNT PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Lead dimensions are not controlled within this area.
- D. All lead dimensions apply before solder dip.
- E. The center lead is in electrical contact with the mounting tab.
- F. The chamfer is optional.

KC (R-PSFM-T3)

- G. Falls within JEDEC TO-220AB
- H. Tab contour optional within these dimensions



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